


FORM PTO-1449 (Colb)	ATTY DOCKET NO. IL9-2000-0079	SERIAL NUMBER 09/847,309
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS' INFORMATION STATEMENT	APPLICANT Alan HARTMN, et al.	
	FILING DATE May 3, 2001	GROUP ART UNIT 2184

U.S. PATENT DOCUMENTS

Examiner's Initials		DOCUMENT NO.	DATE	NAME	CLASS	SUB	FILING DATE
TF	AA	5,394,347	Feb. 1995	Kita et al.			
I	AB	5,623,499	Apr. 1997	Ko et al.			
I	AC	5,918,037	June 1999	Tremblay et al.			
TF	AD	4,991,176	Feb. 1991	Dahbura et al.			
	AE						

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FOREIGN PATENT DOCUMENTS

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OTHER ART (Including Author, Bills, Pertinent Pages, Etc.)

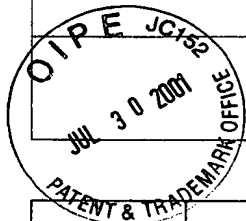
TF	AG	I. Gronau et al., "A Methodology and Architecture for Automated Software Testing", IBM Research Laboratory in Haifa Technical Report, 17 pages, Oct. 2000, Haifa, Israel.
I	AH	"Murphi Description Language and Verifier", previously overviewed in "Protocol Verification as a Hardware Design Aid", by D.L. Dill et al., 1992 <i>IEEE International Conference on Computer Design: VSLI in Computers and Processors</i> , IEEE Computer Society, pp. 522-525, and last updated May 1996, 5 pages. (http://sprout.stanford.edu/dill/murphi/html)
I	AI	Ilan Gronau, et al., "Methodology and architecture for automated software testing", January 11, 2000. (http://www.geocities.com/model_based_testing/online_papers.htm).
TF	AJ	Brian Marick, "The craft of software testing", 1995, Chap. 5, p. 132.
EXAMINER:		DATE CONSIDERED: 5/9/04
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TF	AG	Boris Beizer, "Software testing techniques", Second Edition, 1990, pp. 23-24.
TF	AH	R. Burke, "Black-box regression testing – an automated approach", Fifth International Conference on Testing Computer Software, Washington, DC, June 1988 (pp. 455, 481 in Boris Beizer's Book "Software testing techniques", Second Edition, 1990)
EXAMINER	DATE CONSIDERED: 5/9/09	
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